

Application/Control No. 10/033,175	Applicant(s)/Patent under Reexamination SEEBERGER ET AL.
Examiner	Art Unit
Devesh Khare	1623

				ISSUE	CL	AS	SIF	ICATIO	NC						
		ORIGINAL			INTERNATIONAL CLASSIFICATION										
	ASS	S CLAIMED						NON-CLAIMED							
53		4	07	Н	011	104				1					
CLASS	۷	07	F	009	159				1						
536	5	1.1	4.1	109	2	07	F	009	16553				1		
	18.6	18.7	123.1	123-13					1				1		
	117	17.9	18.5	126					1				1		
549	222								1				1		
435	97								1				1		
DEV (Assi)	ESH K stant Exami	Yhita	ate)9 3\0L (10 (Date)	VISC	OJIA ANNA JIANG, PH.D. Total Claims Allowed: OISORY PATENT EXAMINER O.G. O.G. Print Claim(s) O.G. Print F										

Claims renumbered in the same order as presented by applicant									☐ CPA			☐ T.D.			☐ R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151			181
	2			32			62			92			122			152			182
	3			33			63			93			123			153			183
	4			34			64			94			124			154			184
	5			35			65			95			125			155			185
	6			36			66			96			126			156			186
	7			37			67			97			127			157			187
	8			38			68			98			128			158			188
	9			39			69			99			129			159			189
	10			40			70			100			130			160			190
	11			41			71			101			131			161			191
	12		3	42			72 -			102			132			162			192
	13		4	43			73			103			133			163			193
	14		5	44			74			104		_	134			164			194
	15_		6	45			75			105			135			165			195
	16		678	46			76			106			136			166			196
	17		8	47			77			107			137			167			197
	18		9	48			78			108			138			168			198
	19		10	49			79			109			139			169			199
	20			50			80			110			140			170			200
	21		_	51			81			111			141			171			201
	22			52			82			112			142			172			202
2	23			53			83			113			143			173			203
	24			54			84			114			144			174			204
<u></u>	25			55			85			115			145			175			205
\vdash	26			56			86			116			146			176			206
<u> </u>	27			57			87			117			147			177			207
	28			58			88			118			148			178			208
	29			59			89			119			149			179			209
	30			60		l	90			120			150			180			210